Stabilizing Effect of Resistivity towards ELM-free H-mode Discharge in Lithium-conditioned NSTX

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Outline

> Motivation

- ≻ Review of NSTX Li-conditioned experimental results.
- ≻ Pre-lithium discharge analysis.
- ≻ Post-lithium discharge analysis.
- ≻ Summary and discussion.



Motivation

- In 2008 campaign, NSTX achieved completely ELM-free H-mode discharge after using Li-coated divertor and wall.
- > The pedestal profiles of pressure, and the values of Z_{eff} have been noticeably changed.
- The mechanism behind this ELM-suppression is studied in context of extended magneto-hydrodynamic (MHD) modeling.



Li Coating leads to ELM suppression in NSTX

ELMy H-mode - 129019 no. discharge (black) – NBI heating – 4 MW

<u>ELM free H-mode</u> – **129038** no. discharge (**blue**) – NBI heating – 2 MW

- NBI heating is reduced by 50 % but stored energy is same.
- H-mode confinement time is enhanced by 2 factor.
- Radiation in post lithium study is enhanced substantially.





Changes in profiles and Z_{eff} value after Li-coating (Red curve – Post-Lithium, blue curve-Pre-Lithium)



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R. Maingi et. al., Nucl. Fusion, 52, 083001 (2012).



ELITE analysis indicates post-lithium NSTX pedestal more stable due to profile changes



- The crosshair is the position of experimental equilibrium.
- In post-lithium discharge, the pedestal equilibrium moves away from peelingballooning boundary into stable region.
- The stabilization was attributed to inward shifting of edge pedestal and increase of pedestal width.



The goal and Procedure of study

- Is profile modification alone sufficient to stabilize ELMs in NSTX?
- Or, are there any direct impurity effects (Z_{eff} , radiation, rotation) on ELMs?

Steps of Analysis:

- Ideal MHD analysis of Pre-lithium/Post-lithium discharge.
- Redo of this analysis including 2fluid-correction terms as Hall effect, electron diamagnetic effect and gyro-viscosity.
- Resistive extended MHD analysis with Spitzer model and scanning of Z_{eff} parameters consistent with NSTX experimental data.



NIMROD analysis: Extended MHD equation solver

Continuity Equation:

$$\frac{\partial n_D}{\partial t} + \nabla \cdot (n_D V) = \nabla \cdot (D \nabla n_D) \quad , \quad n_D = \text{Ion density} \quad , \quad n_e \approx n_D$$

Momentum Equation of MHD fluid:

$$\rho \frac{\partial V}{\partial t} + \rho \left(V \cdot \nabla \right) V = -\nabla \left(P_e + P_D \right) + J \times B - \nabla \cdot \Pi$$

Temperature Equations:

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$$n\left[\frac{\partial T_{D,e}}{\partial t} + (V \cdot \nabla)T_{D,e}\right] = -(\gamma - 1)\left[nT_{D,e}(\nabla \cdot V) + \nabla \cdot q_{D,e} + Q_{D,e}\right]$$

Ampere's Law and zero divergence:

$$\nabla \times B = \mu_0 J \quad , \qquad \nabla \cdot B = 0$$

Faraday's law coupled with Generalized Ohm's Law:

$$\frac{\partial B}{\partial t} = -\nabla \times \left[\eta J - V \times B + \frac{1}{ne} \left(J \times B - \nabla p_e + \frac{m_e}{e} \frac{\partial J}{\partial t} \right) \right]$$
2-fluid effects
C. R. Sovinec and NIMROD team, J. Comp. Phys., 195, 355-386 (2004).

Profile Differences between Pre-Lithium and Post-Lithium



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Ideal 2-fluid Model predicts both Pre/Post cases be unstable



What else factor might play catalystic role behind stabilization?



Edge localized modes have resolved structures



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Enhanced resistivity causes stabilization of low-n modes



Spitzer Resistivity:

$$T: \quad \eta(T_e) = \eta_0 Z_{eff} \left(\frac{T_{e0}}{T_e}\right)^{3/2}$$

- η_0 = resistivity at magnetic axis T_{e0} = electron temperature at magnetic axis Z_{eff} = effective atomic number
- > The enhanced resistivity at edge pedestal corresponding to higher Z_{eff} provides complete stabilization.
- > The required value of Z_{eff} is similar with the experimental measured value.

D. Banerjee, P. Zhu and R. Maingi, *Stabilizing effects of enhanced resistivity due to lithium-conditioning on low-n edge localized modes in NSTX*, **under review in Physical Review Letter**



The numerical results are well converged



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Resistive stabilization on low-n ELMs in NSTX is general!

- > The value of Z_{eff} is varied in Spitzer model for pre-lithium case.
- The density and temperature profiles of electron and ion are unchanged.
- n=3,4 are reduced in growth rate and finally become stabilized.
- Growth rates of (n>5) modes are increasing with resistivity.





Summary & Conclusion

- Resistive stabilizing effects on low-n ELMs have been found in 2-fluid model using NIMROD calculations.
- The profile changes alone may not be sufficient for explaining the Li-induced ELM suppression in NSTX.
- ▷ Resistive stabilization of low-n ELMs due to the enhancement in Z_{eff} may explain the Li-induced ELM suppression in NSTX.





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